

Highly Porous SnO₂/TiO₂ Heterojunction Thin-Film Photocatalyst Using Gas-Flow Thermal Evaporation and Atomic Layer Deposition

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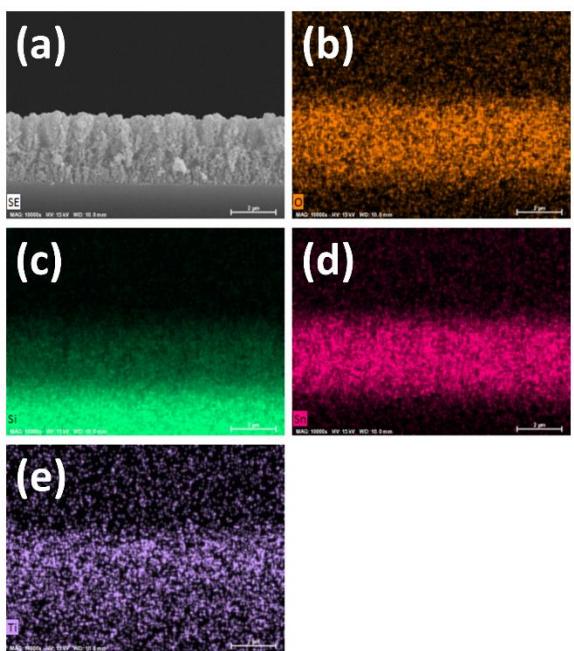


Figure S1. EDX mapping for $\text{SnO}_2/\text{TiO}_2$ -50: (a) lateral SEM image of $\text{SnO}_2/\text{TiO}_2$ -50 of information collection area, (b) O element, (c) Si element (d) Sn element and (e) Ti element.

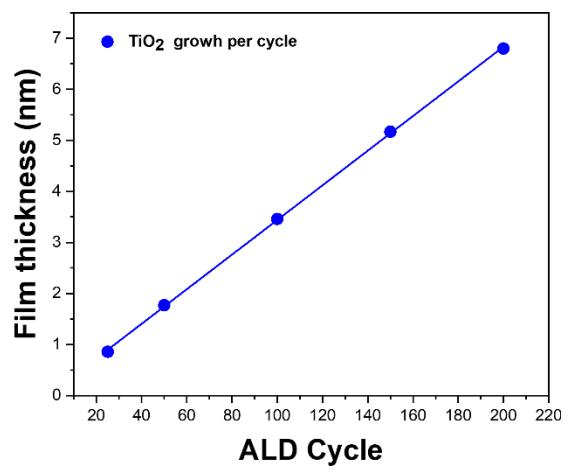


Figure S2. Growth per cycle (GPC) of TiO_2 thin film at 300°C on Si substrate

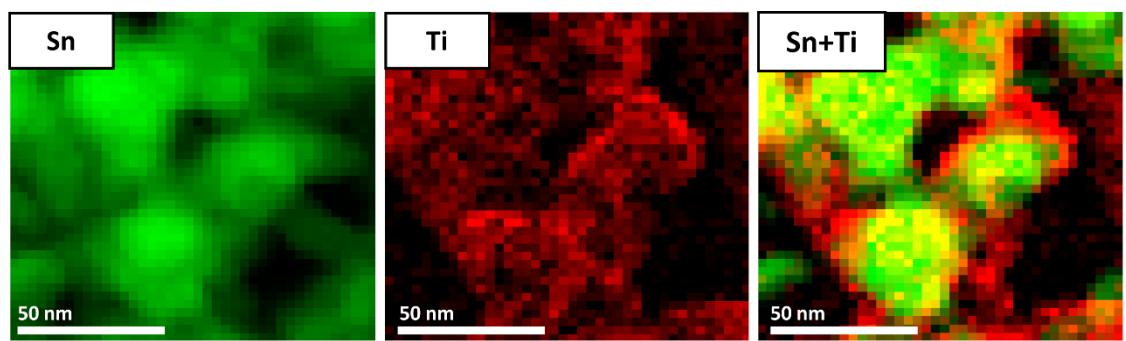


Figure S3. EELS spectrum of $\text{SnO}_2/\text{TiO}_2$ -50. Sn and Ti clearly reveals presence as heterojunction structure.

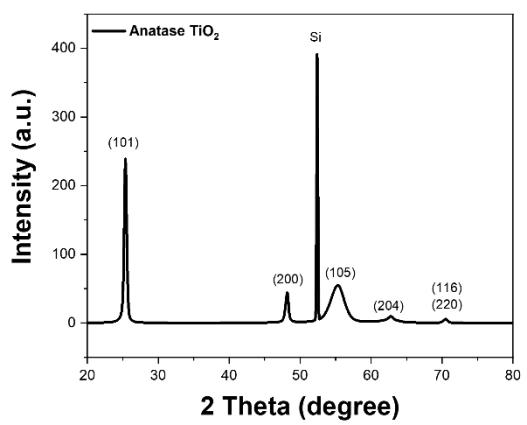


Figure S4. XRD pattern of as-deposited TiO₂ layer by ALD cycles process on Si substrate

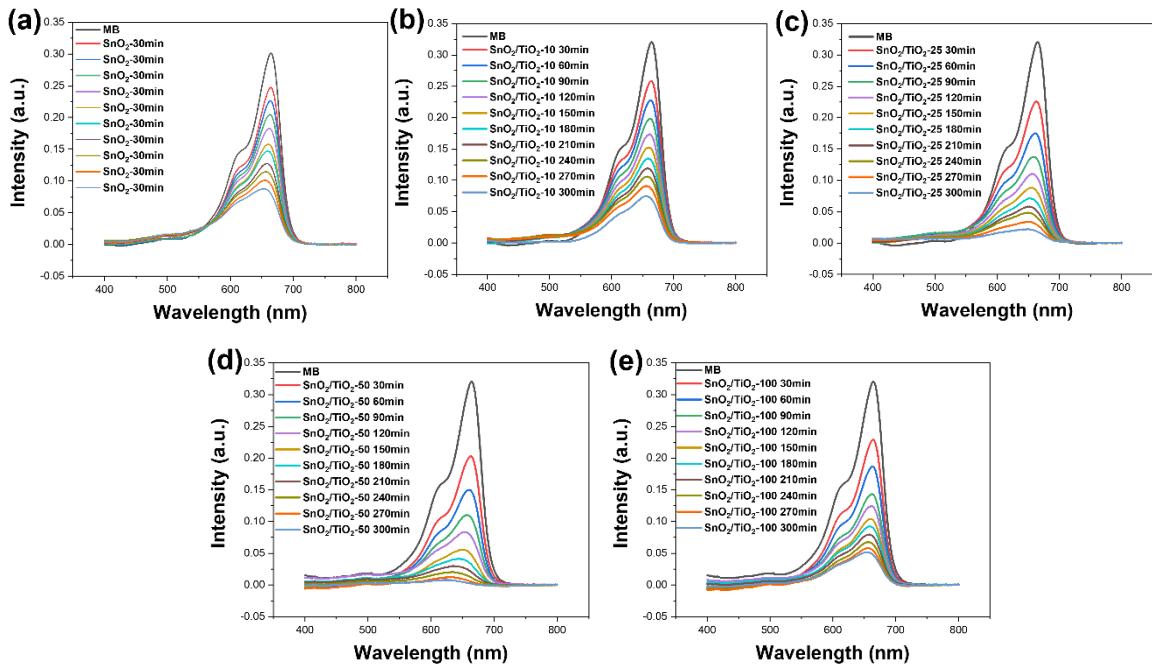


Figure S5. UV-Visible absorbance spectra of photodegradation of methylene blue (a)-(e) by SnO₂ and all SnO₂/TiO₂ with different ALD cycles.

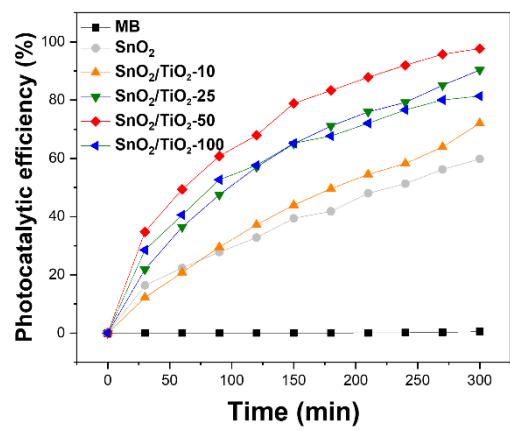


Figure S6. The photocatalytic efficiency (%) with increasing degradation time by SnO₂ and all SnO₂/TiO₂-50 photocatalysts.